

Beam Conditioning Monitor

ATLAS, LHC

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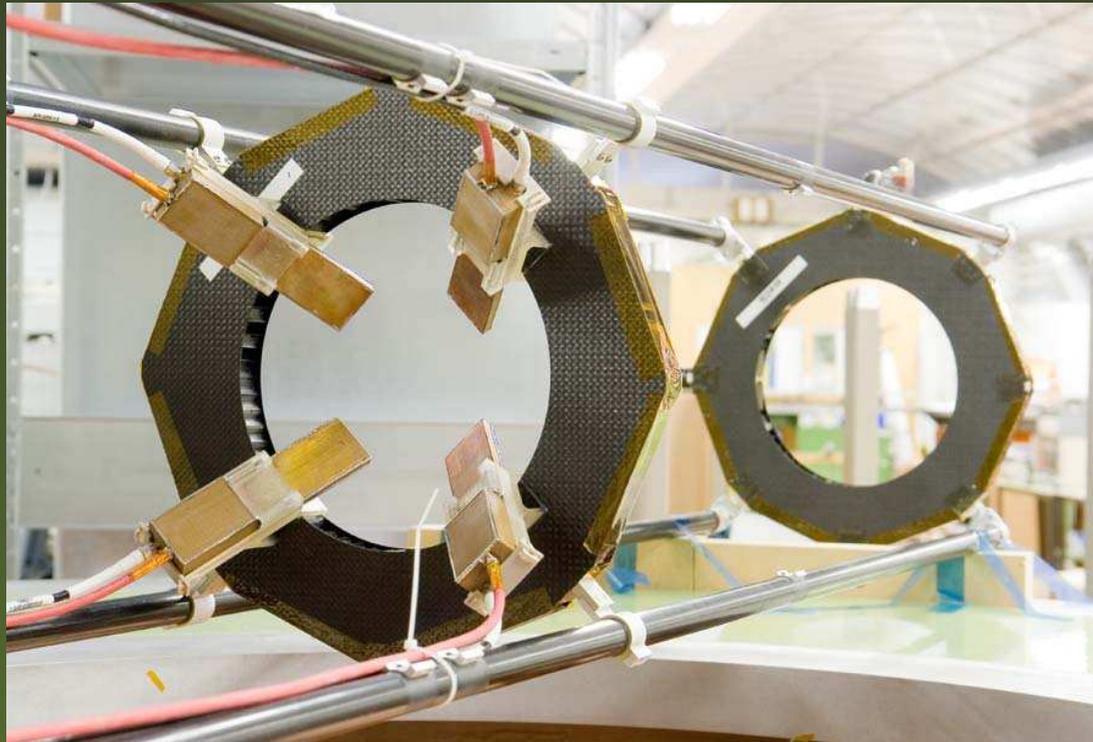
EPF, UiO

This talk

- Introduction to the BCM
- Different setups
- Analysis

BCM

- 8 modules → 8 channels
- $\pm 183\text{cm}$ from $z=0$
- 55mm away from beam pipe



Purpose

- Looking for signs of beam anomalies
 - Beam scraping the TAS collimator, beam-gas interactions
 - Causes background, in worst case damaging the detector
- Information about the beam
 - Luminosity
 - Interaction point(?)

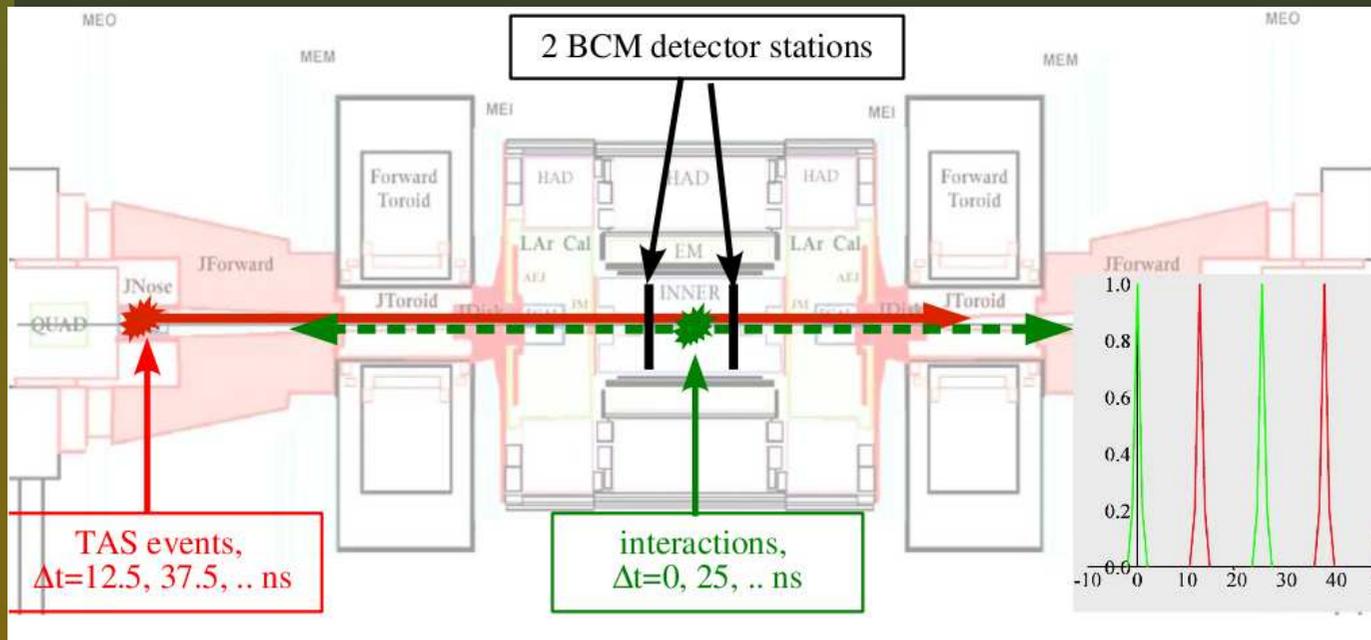
Based on single beam bunch crossings, not integrating the accumulated particle flux.

Principle

- Distinguish between background(TAS, beam-gas) and p-p interactions by time difference
- p-p interactions: each 25ns
- Background events: $\Delta t = 2\Delta z/c$
- $\Delta t = 12.5ns$ when $\Delta z \approx 1.90m$

Principle

- Distinguish between background (TAS, beam-gas) and p-p interactions by time difference

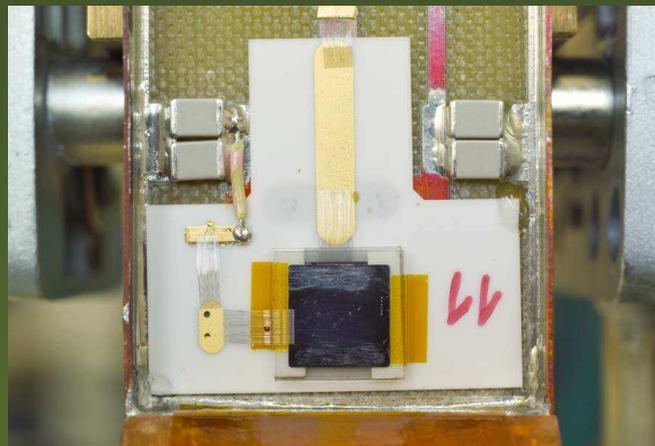


- Beam-gas $z < \Delta z$, interaction point

pCVD diamond

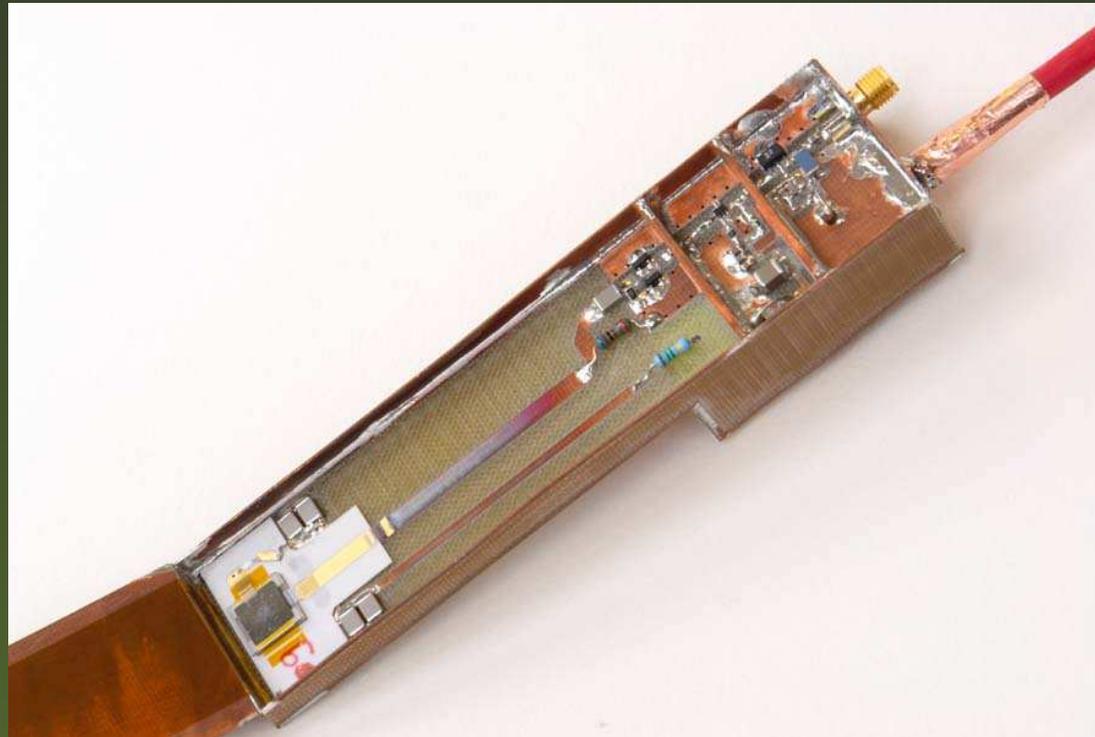
polycrystalline Chemical Vapor Deposition(pCVD) diamond

- Radiation hard
- Fast and short signal, important for high speed environment
- Very low leakage current
- $1\text{cm} \times 1\text{cm} \times 500\mu\text{m}$
- 2 diamonds back to back at 45° to improve SNR



Front-end

- Operated at $\pm 1000\text{V}$ \rightarrow High and narrow current pulse
- Two stage Fotec amplifier



Back-end

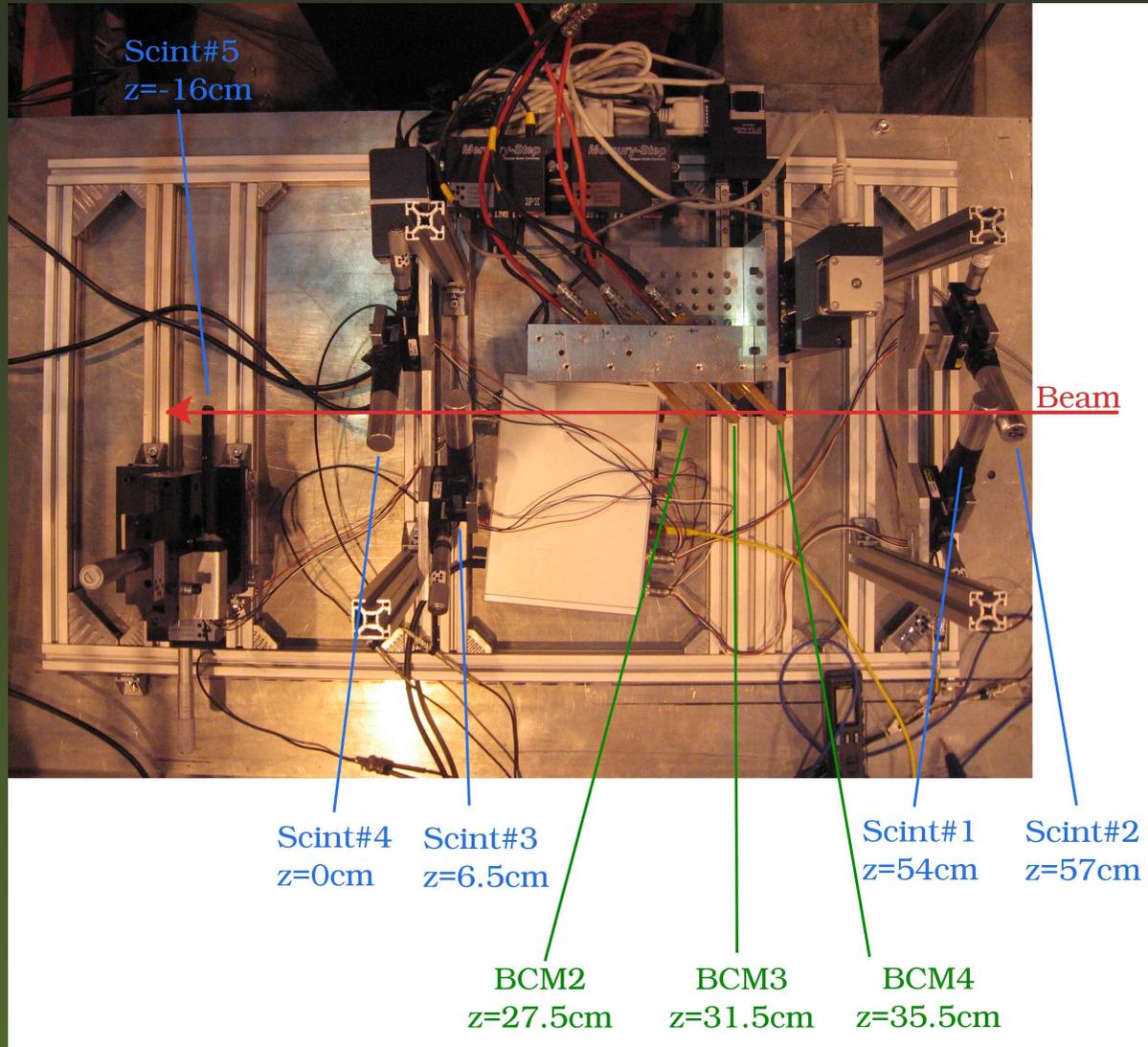
- NINO

- amplifier-discriminator
- Adjustable threshold
- ~15m coax-cable

- FPGA

- Field-programmable gate array
- Programmable logic components
- ~100m optical fiber

Test beam setup



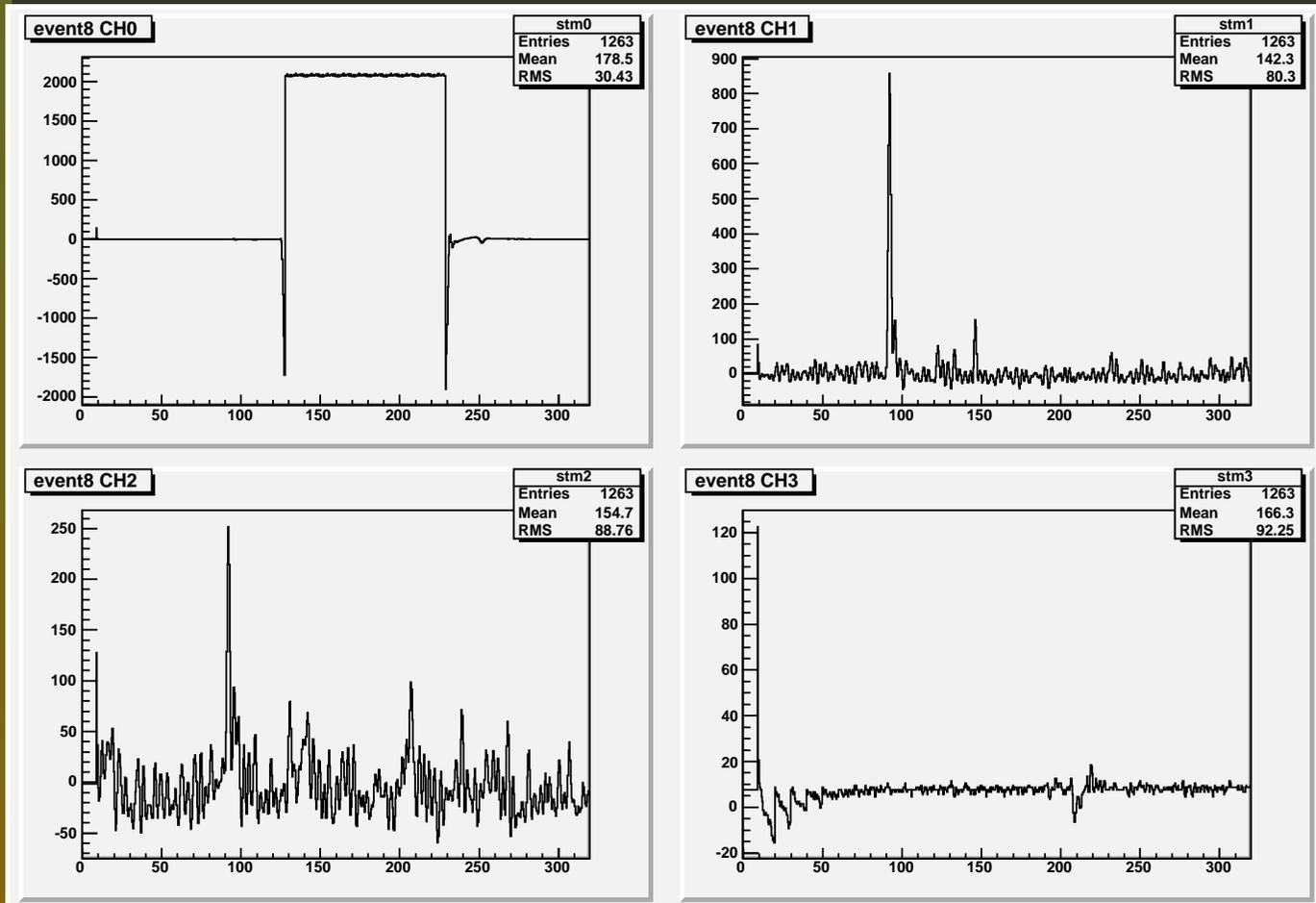
Position scan, analog, H6

- Ch0: Trigger → ADC(CAEN V1729)
- Ch1: Fotec → Ampl.(ORTEC FTA820) → Discr.(ORTEC QUAD CFD) → ADC
- Ch2: Fotec → Ampl.(ORTEC FTA820) → Discr.(ORTEC QUAD CFD) → ADC
- Ch3 : Empty

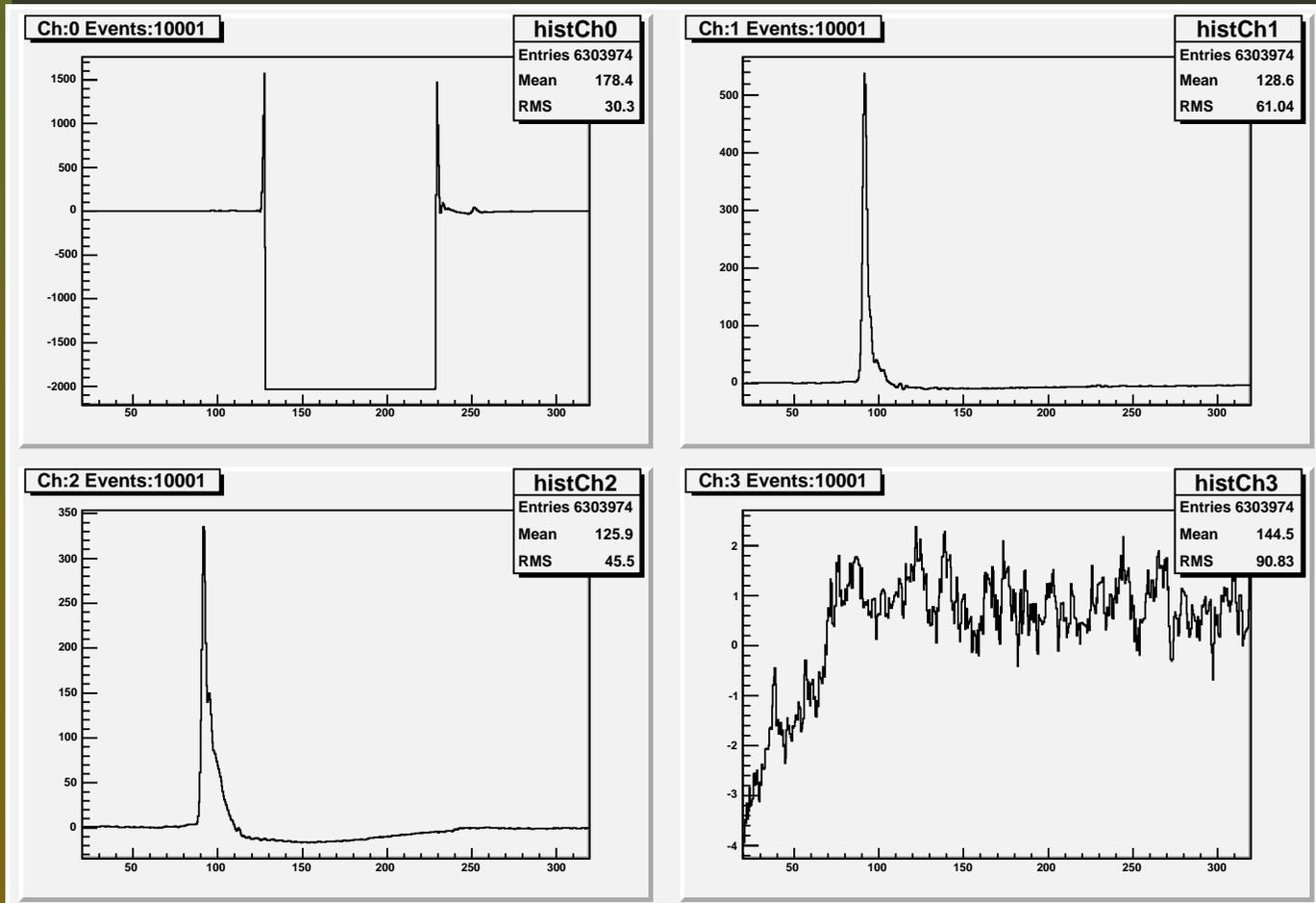
Preveessin



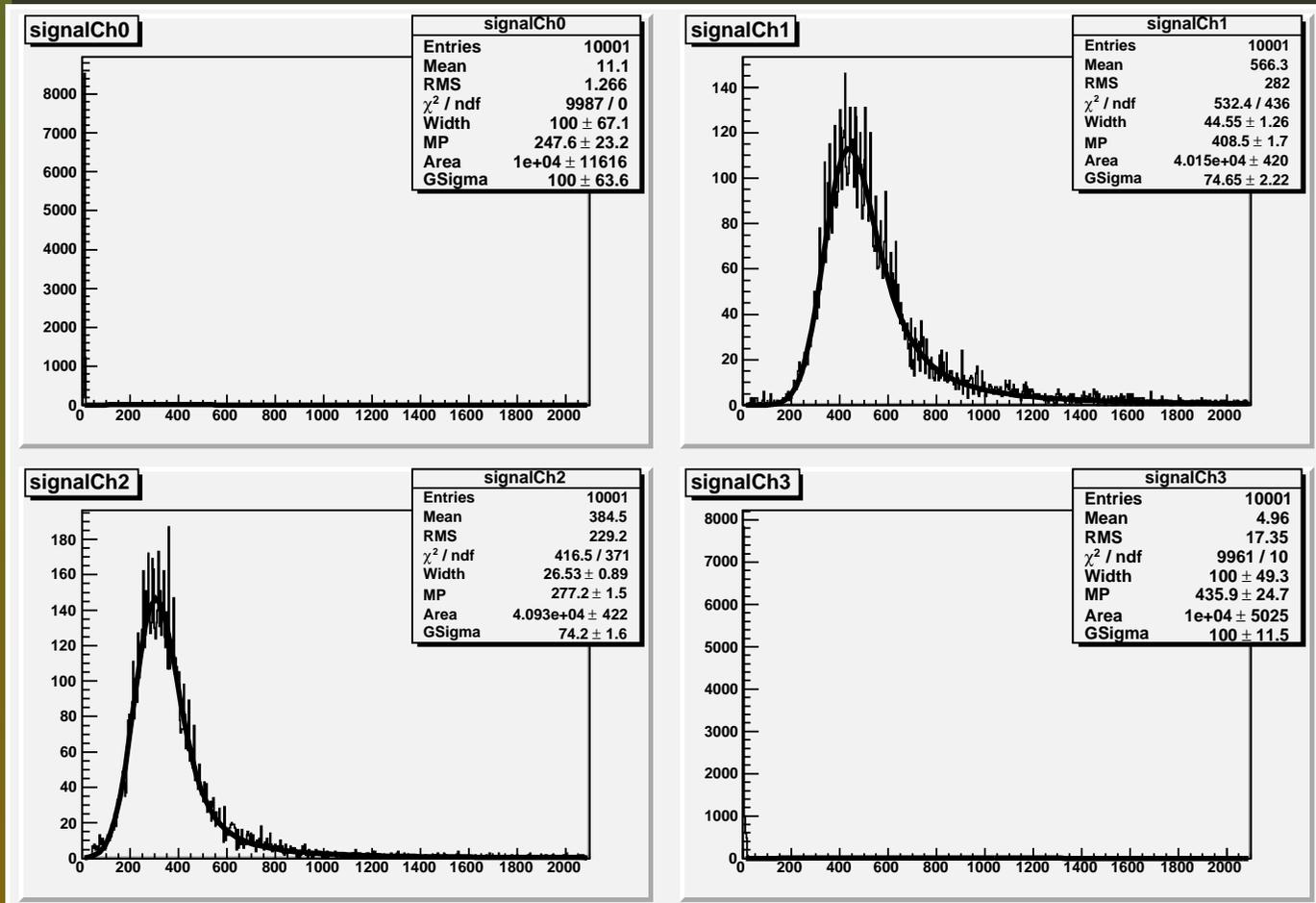
Single event



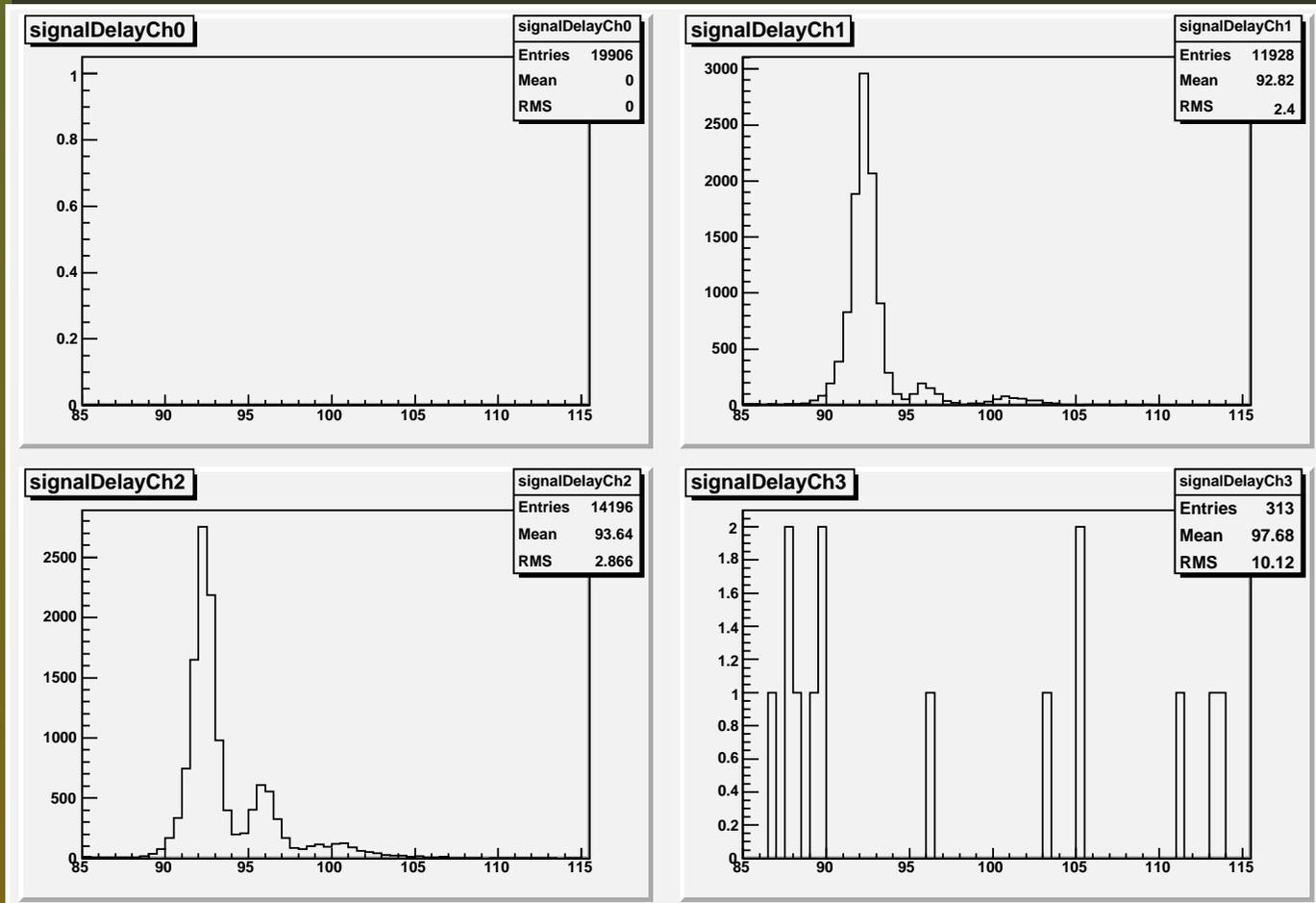
All event



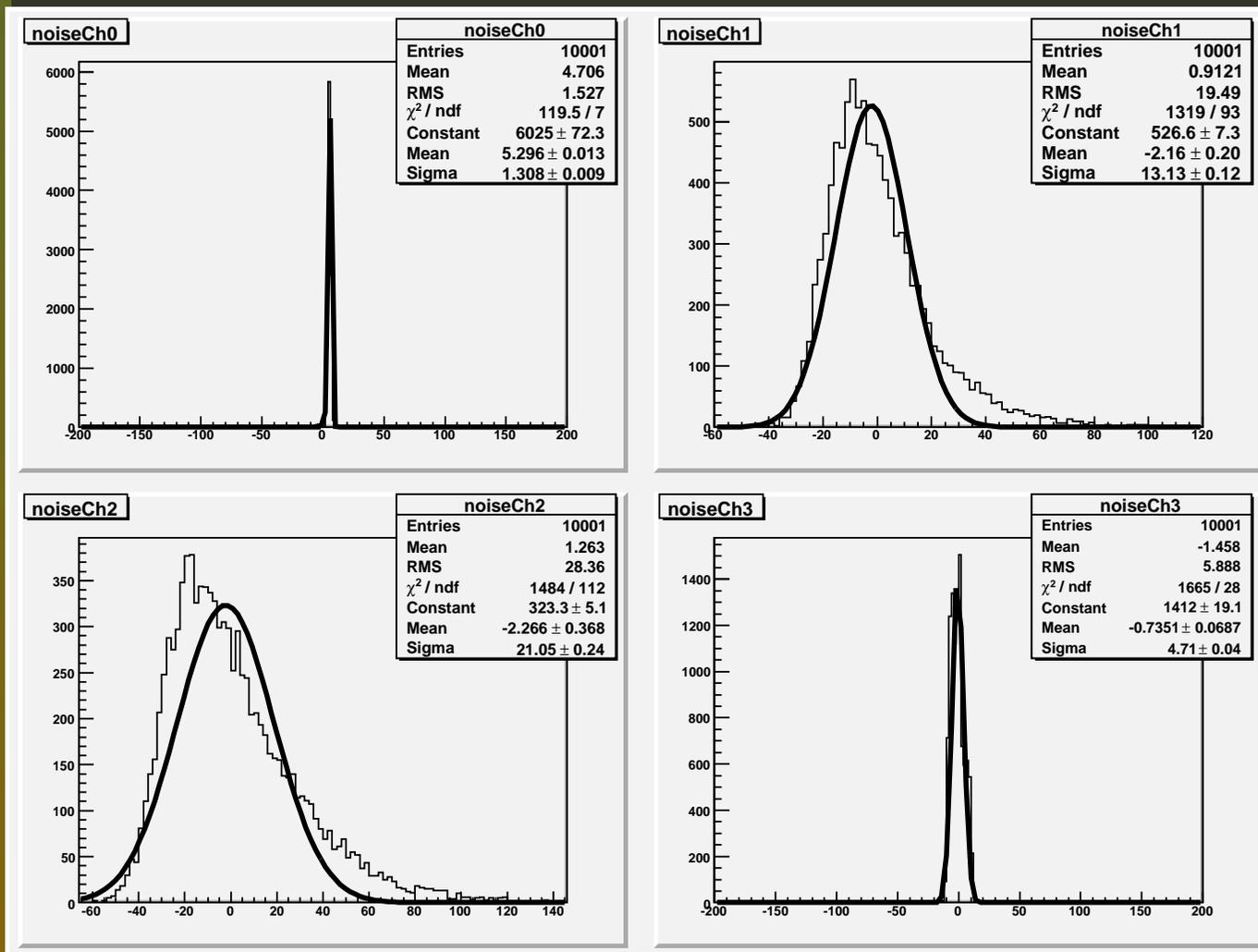
Signal peak



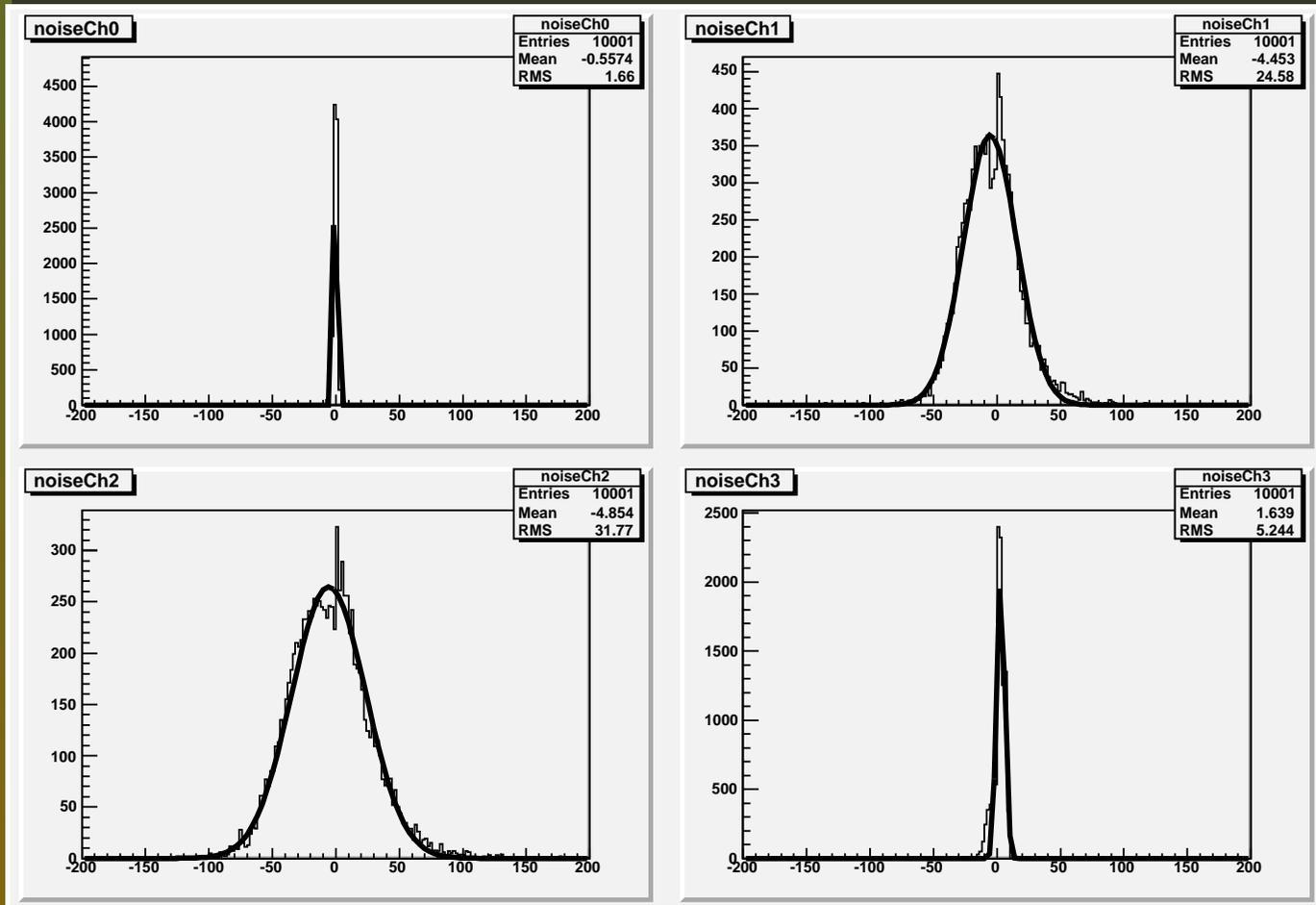
Signal Delay



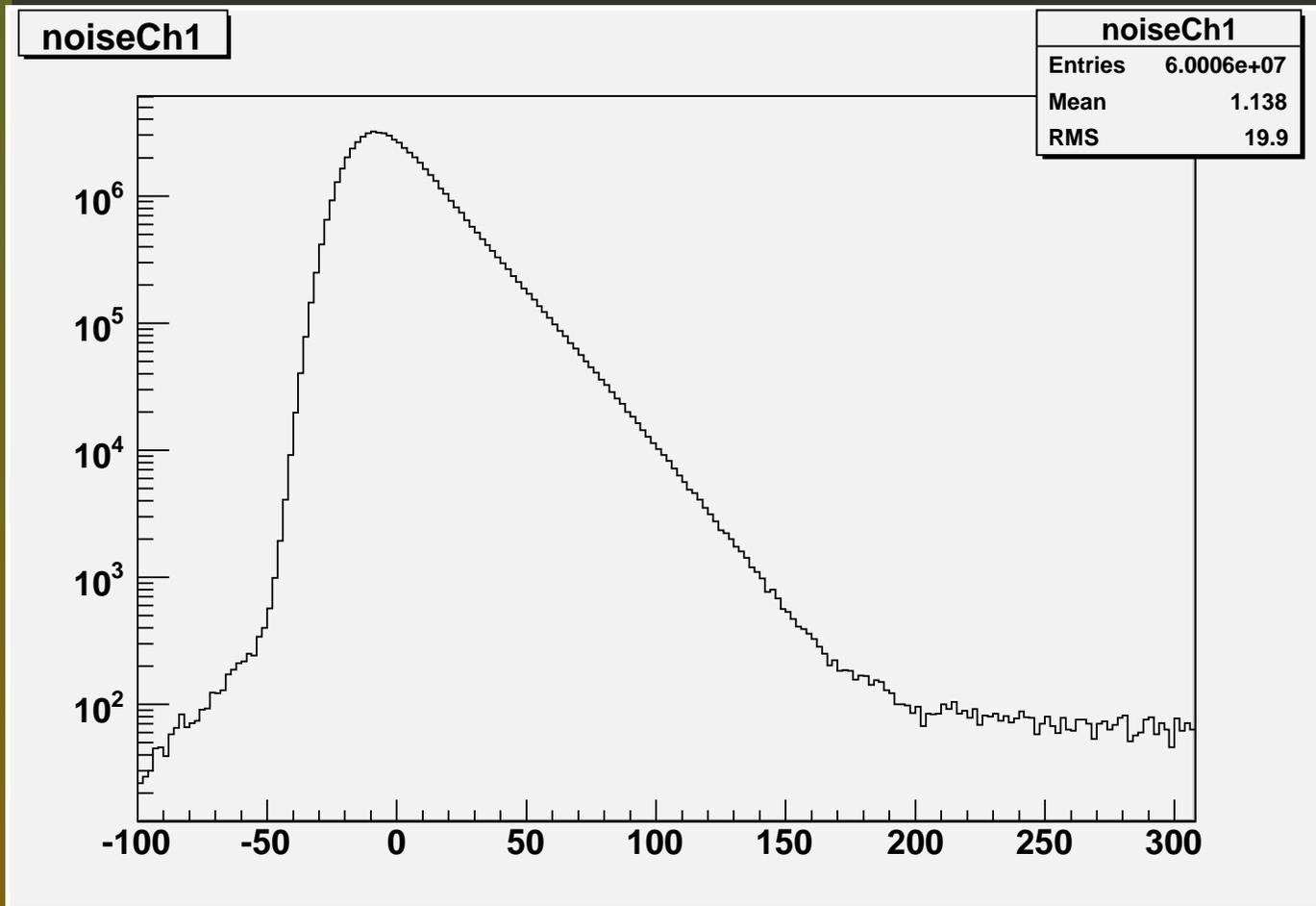
Noise



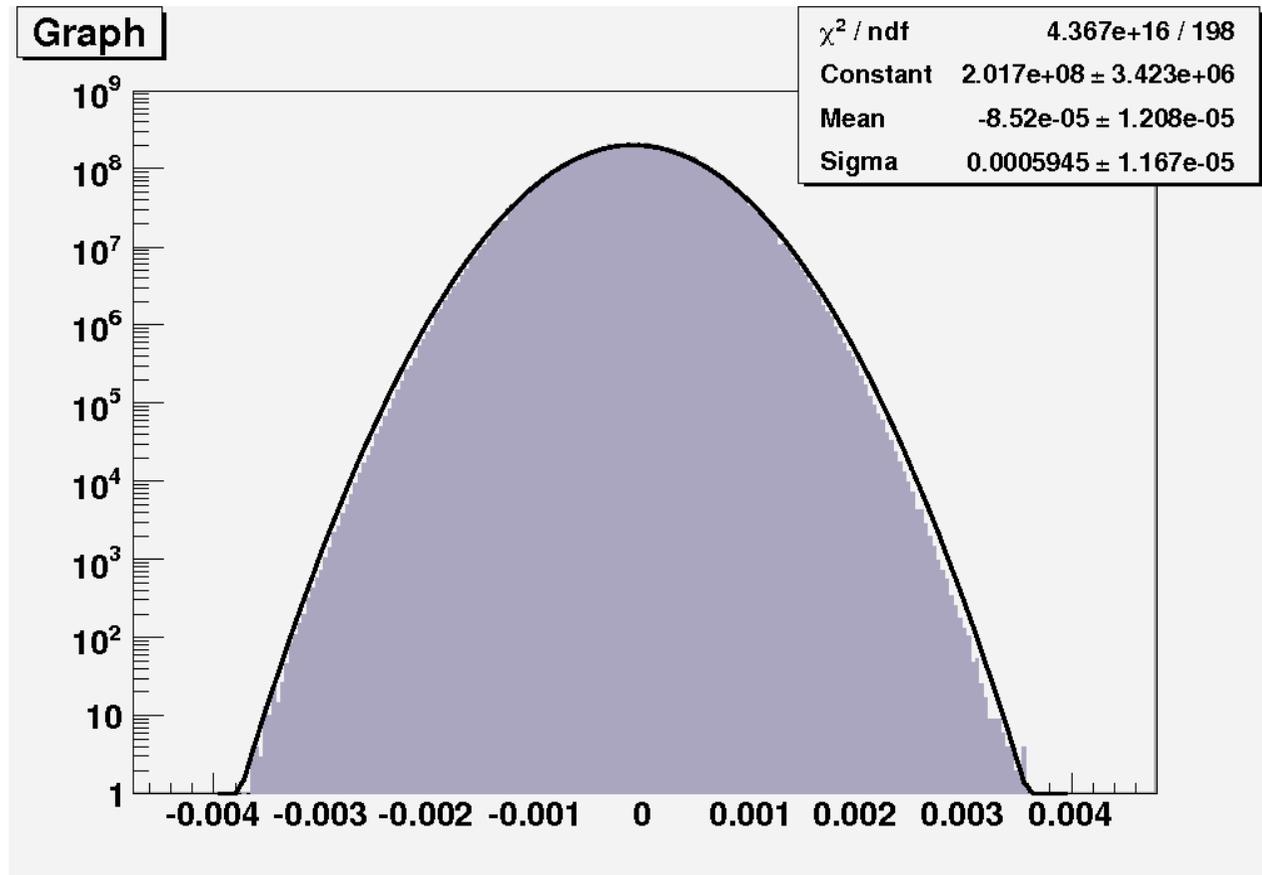
Noise



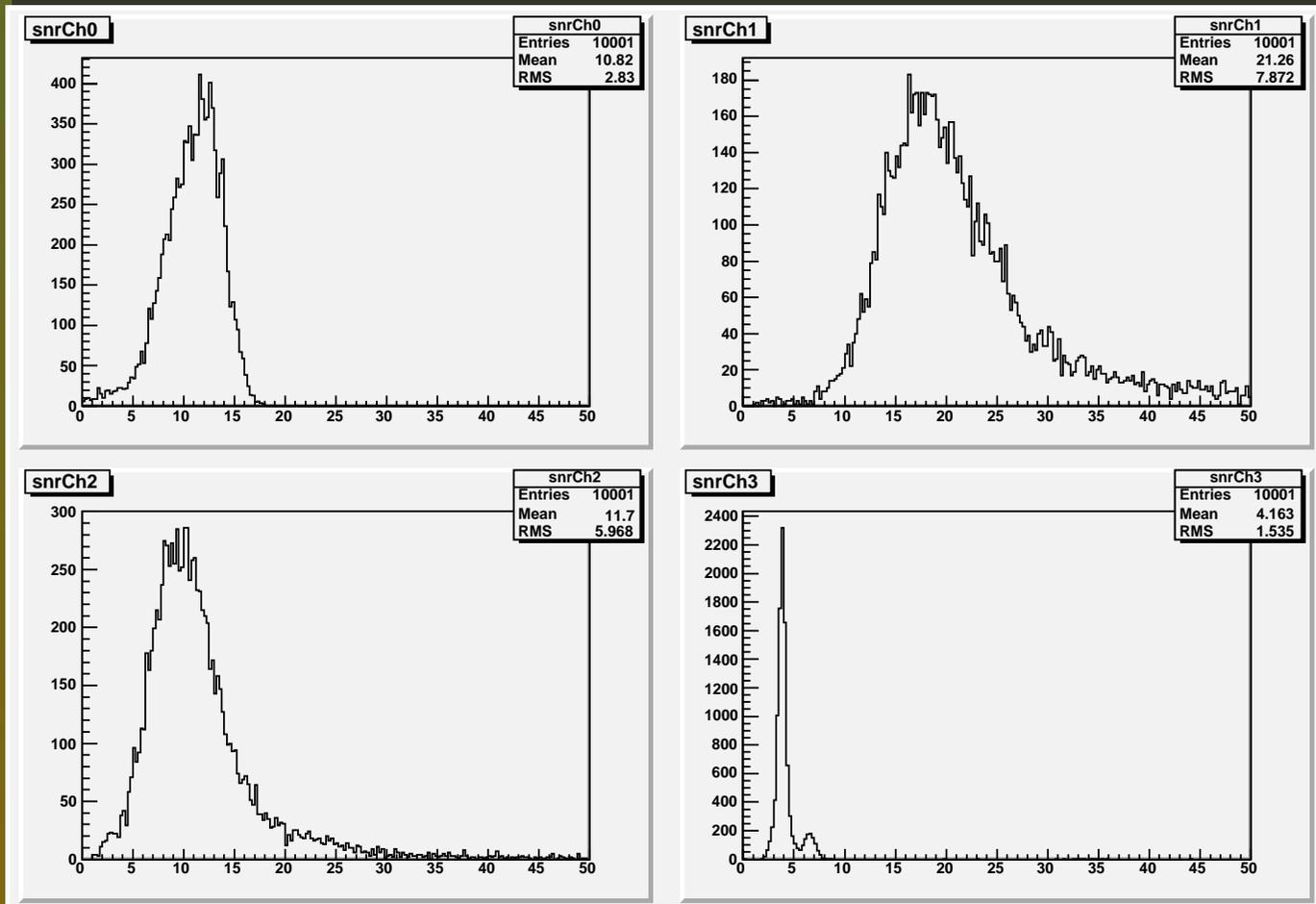
Noise, high stat



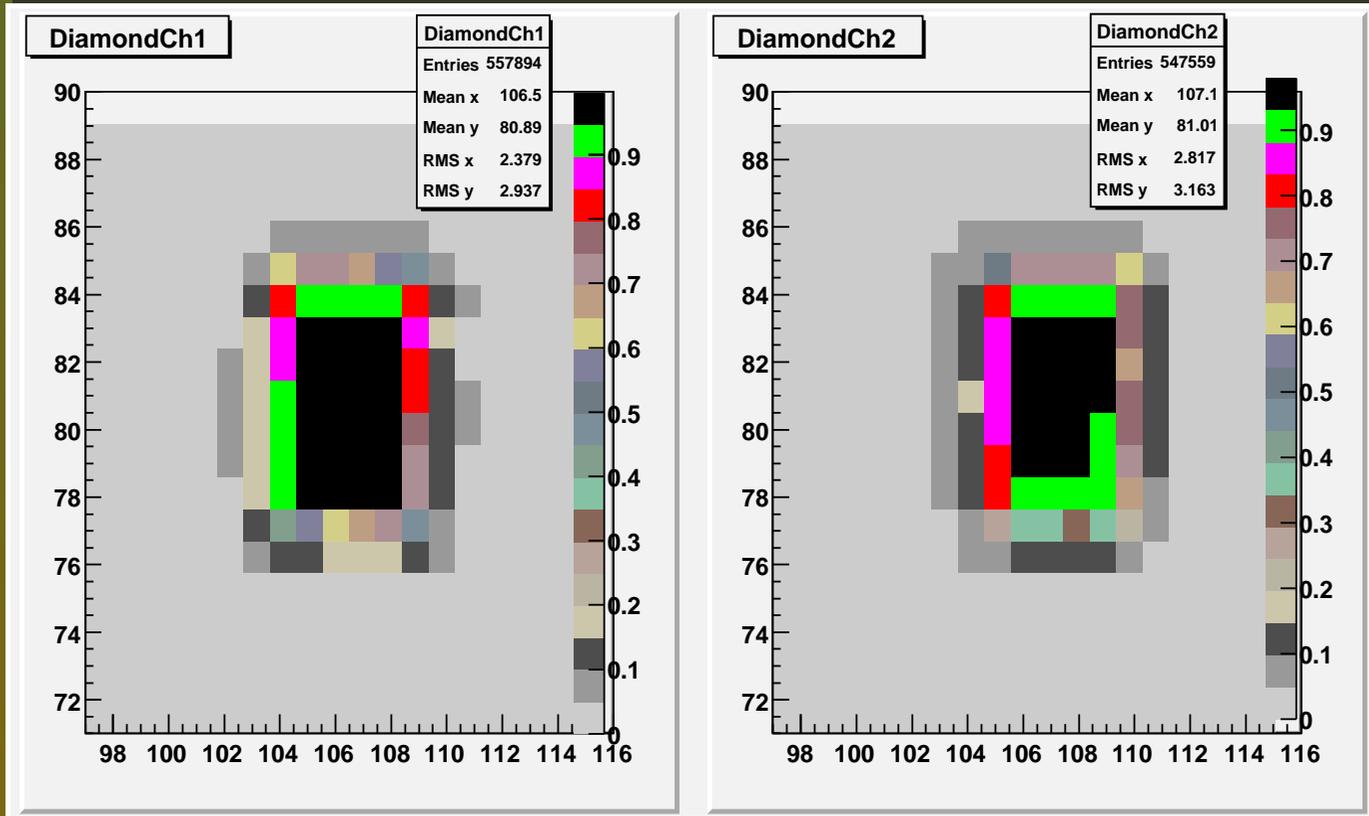
Noise, Fotec



SNR



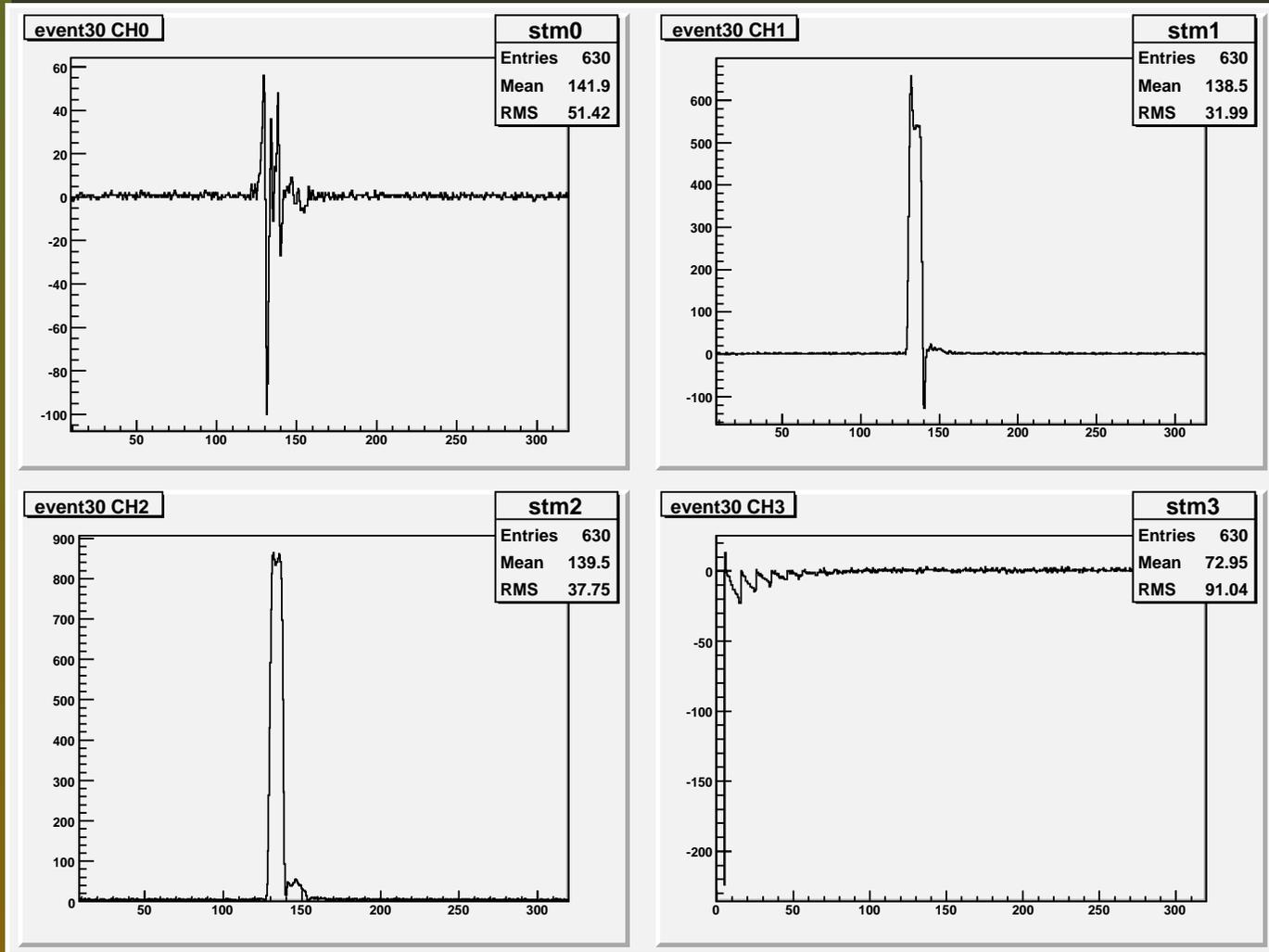
Position scan



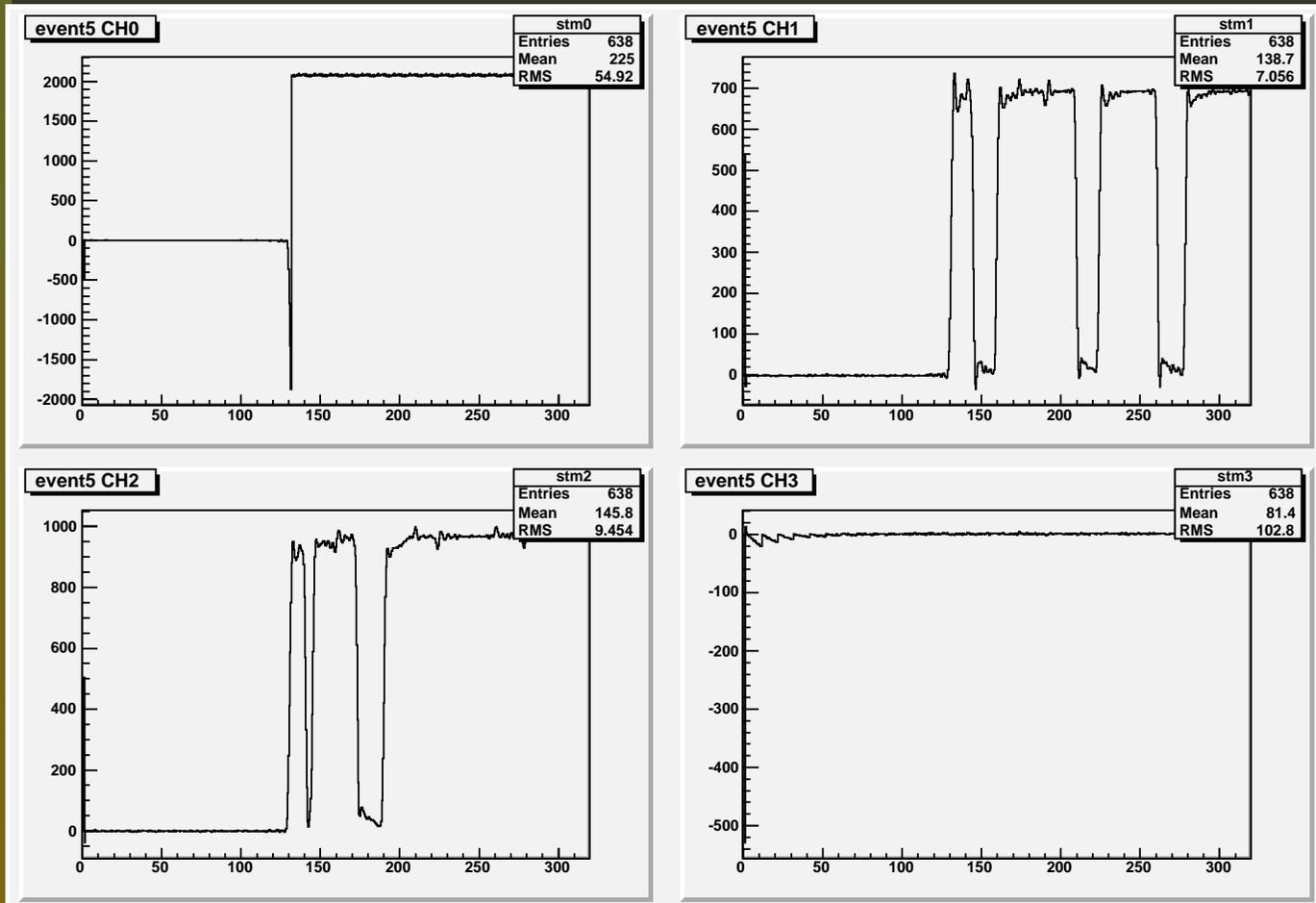
NINO Threshold scan, digital, H8

- Ch0: Fotec → NINO#1 → ADC
- Ch1: Fotec → NINO#2 → Attenuator → ADC
- Ch2: Fotec → NINO#2 → Attenuator → ADC
- Ch3 : Empty

Single event, Thr=70mV



SingleEvent, Thr=20mV



Efficiency

